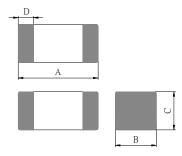
# **High Current Ferrite Chip Bead(Lead Free)**

HCB1005KF-Series

#### 1. Features

- 1. Monolithic inorganic material construction.
- 2.Low DC resistance structure of electrode to prevent wasteful electric power consumption.
- 3. Closed magnetic circuit avoids crosstalk.
- 4. Suitable for flow and reflow soldering.
- 5. Shapes and dimensions follow E.I.A. spec.
- 6. Available in various sizes.
- 7. Excellent solderability and heat resistance.
- 8. High reliability.
- 9. This component is compliant with RoHS legislation and also support lead-free soldering.

## 2.Dimensions

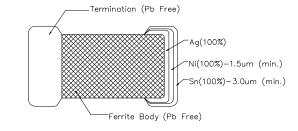


Chip Size					
Α	1.00±0.10				
В	0.50±0.10				
С	0.50±0.10				
D	0.25±0.10				

Units: mm

# 3.Part Numbering





# 4.Specification

Bullwill Part Number	Impedance (Ω)	Test Frequency (MHz)	DC Resistance (Ω) max.	Rated Current (mA)
HCB1005KF-100T20	10±25%	100	0.10	2000
HCB1005KF-300T20	30±25%	100	0.10	2000
HCB1005KF-600T20	60±25%	100	0.10	2000
HCB1005KF-800T20	80±25%	100	0.10	2000
HCB1005KF-900T20	90±25%	100	0.10	2000
HCB1005KF-101T20	100±25%	100	0.10	2000
HCB1005KF-121T20	120±25%	100	0.10	2000
HCB1005KF-221T15	220±25%	100	0.15	1500
HCB1005KF-301T15	300±25%	100	0.15	1500

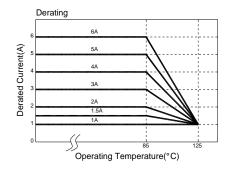
# 5. Reliability and Test Condition

Item	Performan	Test Condition		
Series No.	FCB FCM HCB HPB HFB FCA	FCI FHI FCH HCI		
Operating Temperature	-55~+125 $^{\circ}$ C (Including self-temperature rise)			
Storage Temperature	-55~+125℃	-40~+85℃		
Impedance (Z)				
Inductance (Ls)			HP4291A, HP4287A+16092A	
Q Factor	Refer to standard electrical characteristics lis	st		
DC Resistance			HP4338B	
Rated Current			**	
Temperature Rise Test	30°C max. (△T)	1. Applied the allowed DC current. 2. Temperature measured by digital surface thermometer.  Preheat: 150°C,60sec. Solder: Sn-Ag3.0-Cu0.5 Solder tamperature: 260±5°C Flux for lead free: rosin Dip time: 10±0.5sec.		
Solder heat Resistance	,,	o mechanical damage. emaining terminal electrode:70% min.	Preheating Dipping Natural cooling  260°C  150°C  60  10±0.5  second	
Solderability	More than 90% of the terminal electrode should be covered with solder.		Preheat: 150℃,60sec. Solder: Sn-Ag3.0-Cu0.5 Solder tamperature: 245±5℃ Flux for lead free: rosin Dip time: 4±1sec.	
Terminal strength	The terminal electrode and the dielectric mus not be damaged by the forces applied on the right conditions.	t	For FCB FCM HCB HPB HFB FCI FHI FCH HCI: Size Force (Kfg) Time(sec) 1005 0.2 1608 0.5 2012 0.6 3216 1.0 >25 3225 1.0 4516 1.0 4532 1.5 5750 2.0 For FCA: Size Force (Kfg) Time(sec) 3216 0.5 >25	
Flexture strength	The terminal electrode and the dielectric must not be damaged by the forces applied on the right conditions.	//\ \ \	Solder a chip on a test substrate, bend the substrate by 2mm (0.079in)and return.	
Bending Strength	The ferrite should not be damaged by Forces applied on the right condition.	0.5(0.02)	Size         mm(inches)         P-Kgf           1608         0.80(0.033)         0.3           2012         1.40(0.055)         1.0           FCA3216         2.00(0.079)         1.5           3216         3225         2.00(0.079)         2.5           4516         4532         2.70(0.106)         2.5           5750         2.70(0.106)         2.5	
Random Vibration Test	Appearance: Cracking, shipping and any oth characteristics should not be allowed.  Impedance: within±30%	Frequency: 10-55-10Hz for 1 min. Amplitude: 1.52mm Directions and times: X, Y, Z directions for 2 hours. A period of 2 hours in each of 3 mutually perpendicular directions (Total 6 hours).		

Item	Perfo	rmace	Test Condition
Loading at High Temperature	Appearance: no damage.  Impedance: within±30%of initial value.		Temperature: 125±5°C (bead),85±5°C (inductor) Applied current: rated current. Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Humidity	Inductance: within±10%of initial value. Q: within±30%of initial value. (FCI FHI Q: within±20%of initial value. (HCI)	Humidity: 90~95%RH. Temperature: 40±2°C. Temperature: 60±2°C.(HCI) Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.	
Thermal shock	Appearance: no damage.  Impedance: within±30%of initial value. Inductance: within±10%of initial value. Q: within±30%of initial value. (FCI FHI FCH) Q: within±20%of initial value. (HCI)		For FCB FCM HCB HPB HFB FCA:  Condition for 1 cycle  Step1: -55±2°C 30±3 min.  Step2: +125±5°C 30±3 min.  Number of cycles: 5  For FCI FHI FCH HCI:  Condition for 1 cycle  Step1: -40±2°C 30±3 min.  Step2: +85±5°C 30±3 min.  Number of cycles: 100  Measured at room temperature after placing for 2 to 3 hrs.
Low temperature storage test		Temperature: -55±2°C.  Duration: 1008±12hrs.  Measured at room temperature after placing for 2 to 3hrs.	
Drop	a: No mechanical damage b: Impedance change: ±30%	Drop 10 times on a concrete floor from a height of 75cm	

# \*\*Derating Curve

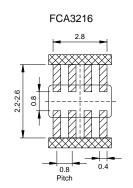
For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over  $85^{\circ}\mathbb{C}$ , the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



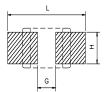
# 6. Soldering and Mounting

## 6-1. Recommended PC Board Pattern

			Pattern ow Sold	• • • •				
Series	Туре	A(mm)	B(mm)	C(mm)	D(mm)	L(mm)	G(mm)	H(mm)
FCB	1005	1.0±0.10	0.50±0.10	0.50±0.10	0.25±0.10	2.10	0.50	0.55
FCM	1608	1.6±0.15	0.80±0.15	0.80±0.15	0.30±0.20	2.60	0.60	0.80
HCB	2012	2.0±0.20	1.25±0.20	0.85±0.20	0.50±0.30	3.00	1.00	1.00
HPB	2012	2.0±0.20	1.25±0.20	1.25±0.20	0.50±0.30	3.00	1.00	1.00
HFB	2520	2.5±0.20	2.00±0.20	1.60±0.20	0.50±0.30	3.90	1.50	1.50
FCI	3216	3.2±0.20	1.60±0.20	1.10±0.20	0.50±0.30	4.40	2.20	1.40
FHI	3225	3.2±0.20	2.50±0.20	1.30±0.20	0.50±0.30	4.40	2.20	3.40
FCH	4516	4.5±0.20	1.60±0.20	1.60±0.20	0.50±0.30	5.70	2.70	1.40
HCI	4532	4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30	5.90	2.57	4.22
UHI	5750	5.7±0.20	5.00±0.30	1.80±0.20	0.50±0.30	8.00	4.00	5.80



Land
Solder Resist



PC board should be designed so that products are not sufficient under mechanical stress as warping the board.

Products shall be positioned in the sideway direction against the mechanical stress to prevent failure.

#### 6-2. Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

BULLWILL P4.

#### 6-2.1 Lead Free Solder re-flow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1.

#### 6-2.2 Solder Wave:

Wave soldering is perhaps the most rigorous of surface mount soldering processes due to the steep rise in temperature seen by the circuit when immersed in the molten solder wave, Due to the risk of thermal damage to products, wave soldering of large size products is discouraged. Recommended temperature profile for wave soldering is shown in Figure 2.

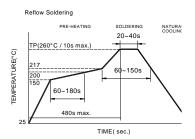
#### 6-2.3 Soldering Iron(Figure 3):

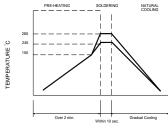
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Note : Preheat circuit and products to 150°C
   350°C tip temperature for Ferrite chip bead (max)
- ducts to 150°C

   Never contact the ceramic with the iron tip
  Ferrite chip bead (max)

   1.0mm tip diameter (max)
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- · Limit soldering time to 3 sec.





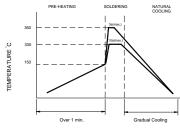


Figure 1. Re-flow Soldering(Lead Free)

Figure 2. Wave Soidering

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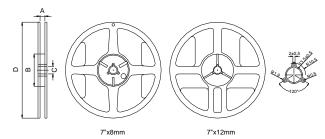
#### 6-2.4 Solder Volume:

Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in right side:



# 7. Packaging Information

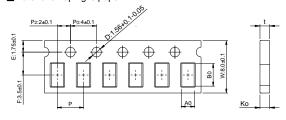
### 7-1. Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	9.0±0.5	60±2	13.5±0.5	178±2
7"x12mm	13.5±0.5	60±2	13.5±0.5	178±2

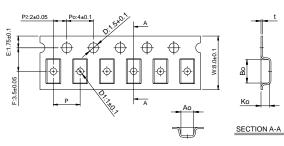
#### 7-2.1 Tape Dimension / 8mm

## ■Material of taping is paper



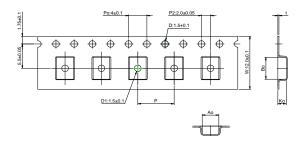
Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
FCB.FCM.HCB	100505	1.12±0.03	0.62±0.03	0.60±0.03	2.0±0.10	0.60±0.03	none
HPB.HFB.FCI	160808	1.85±0.05	1.05±0.05	0.95±0.05	4.0±0.10	0.95±0.05	none
FHI.FCH.HCI	201209	2.30±0.05	1.50±0.05	0.95±0.05	4.0±0.10	0.95±0.05	none

#### ■Material of taping is plastic



Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
FCB,FCM	160808	1.95±0.10	1.05±0.10	1.05±0.10	4.0±0.10	0.23±0.05	none
HCB,HPB	201209	2.25±0.10	1.42±0.10	1.04±0.10	4.0±0.10	0.22±0.05	1.0±0.10
HFB.FCI	201212	2.35±0.10	1.50±0.10	1.45±0.10	4.0±0.10	0.22±0.05	1.0±0.10
FHI.FCH	321611	3.50±0.10	1.88±0.10	1.27±0.10	4.0±0.10	0.22±0.05	1.0±0.10
HCI	322513	3.42±0.10	2.77±0.10	1.55±0.10	4.0±0.10	0.22±0.05	1.0±0.10
FCA	321609	3.40±0.10	1.77±0.10	1.04±0.10	4.0±0.10	0.22±0.05	1.0±0.10

#### 7-2.2 Tape Dimension / 12mm

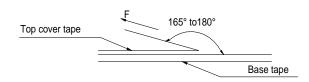


Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
FCB,	451616	4.95±0.1	1.93±0.1	1.93±0.1	4.0±0.1	0.24±0.05	1.5±0.1
HCB.FCM	453215	4.95±0.1	3.66±0.1	1.85±0.1	8.0±0.1	0.24±0.05	1.5±0.1
FCI	575018	6.10±0.1	5.40±0.1	2.00±0.1	8.0±0.1	0.30±0.05	1.5±0.1

## 7-3. Packaging Quantity

Chip Size	575018	453215	451616	322513	321611	201212	201209	160808	100505
Chip / Reel	1000	1000	2000	2500	3000	2000	4000	4000	10000
Inner box	4000	4000	8000	12500	15000	10000	20000	20000	50000
Middle box	20000	20000	40000	62500	75000	50000	100000	100000	250000
Carton	40000	40000	80000	125000	150000	100000	200000	200000	500000
Bulk (Bags)	7000	12000	20000	30000	50000	100000	150000	200000	300000

## 7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed
(℃)	(%)	(hPa)	mm/min
5~35	45~85	860~1060	300

# **Application Notice**

Storage Conditions

To maintain the solderability of terminal electrodes:

- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
  - 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
  - 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
  - 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

# Impedance Frequency Characteristics(Typical)

